

**Issue Classification**

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/719,758	PARKER ET AL.	
Examiner	Art Unit	
Lei Yao, Ph.D.	1642	

ISSUE CLASSIFICATION												
ORIGINAL					CROSS REFERENCE(S)							
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
530		187.1			530	388.1						
INTERNATIONAL CLASSIFICATION					435	326						
C	0	7	K	16/00								
C	0	7	K	16/18								
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<i>Ce Yao</i> (Assistant Examiner)	8-23-05 (Date)	<i>Sheela J. Huff</i> <i>Sheela J. Huff</i> (Primary Examiner)	Total Claims Allowed: 5
<i>Kn</i> (Legal Instruments Examiner)	9/2/05 (Date)	8/23/05 (Date)	O.G. Print Claim(s) 1
			O.G. Print Fig. none

[illegible]